

Application/Control No.	Applicant(s)/Patent under Reexamination						
10/777,677	STONE ET AL.						
Examiner	Art Unit						
Nouven T Ha	2831						

0	RIGINAL		CROSS REFERENCE(S)											
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)											
361	306.1	361	306.3	301.4	313	321.1	321.2							
INTERNATION	AL CLASSIFICATION	257	313	315										
H 0 1 G	4/228													
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Nguyen. T. Ha 5/20/2005
(Assistant Examiner) (Date)

DEAN A. REICHARD

SUPERVISORY PATENT EXAMINER

TECHNOLOGY CENTER 2800
(Primary Examiner)

TECHNOLOGY CENTER 2800
(Primary Examiner)

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Print Clalm(s) Print Fig.
1 2

Claims renumbered in the same order as presented by applicant								☐ CPÃ			☐ T.D.			☐ R.1.47				
Final	Original	2/2/7	Final	Original		Final	Original	Final	Original		Final	Original		Final	Original		Final	Original
1	1	=		31			61		91			121			151			181
2	2 .			32			62		92			122			152			182
	3			33			63		93			123			153			183
	4	- 1		34			64		94			124			154			184
3	5	=		35			65		95			125			155			185
4	6	=		36			-66		96			126			156			186
5	7	>		37			67		97			127			157			187
	8	-		38			68		98			128			158			188
	9			39			69		99			129			159			189
	10			40			70		100			130			160			190
	11			41			71		101			131			161			191
	12			42			72		102			132			162			192
	13			43			73		103			133			163			193
	14			44		L	74		104			134			164			194
	15			45			75		105			135			165			195
	16	N/		46			76		106			136			166			196
	17			47			77		107			137			167			197
6_	18	-		48			78		108			138			168			198
	19			49			79		109			139			169			199
	20			50			80		110			140			170			200
	21			51			81		111			141			171			201
	22			52			82		112			142			172			202
	23			53			83		113			143			173			203
	24			54			84		114			144			174			204
	25			55			85		115			145			175			205
	26			56			86		116			146			176			206
	27			57			_87		117			147			177			207
	28			58			88		118			148			178			208
	29			59			89		119			149			179			209
	30		I	60			90		120			150			180			210